TOSHIBA 2SC3148

TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

2 S C 3 1 4 8

SWITCHING REGULATOR AND HIGH VOLTAGE.
SWITCHING APPLICATIONS.

HIGH SPEED DC-DC CONVERTER APPLICATIONS.

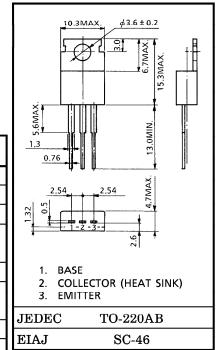
- Excellent Switching Times (IC=0.8A) $t_r=1.0\mu s$ Max., $t_f=1.0\mu s$ Max.
- High Collector-Emitter Breakdown Voltage: VCEO=800V

MAXIMUM RATINGS (Ta = 25°C)

| CHARACTI | SYMBOL | RATING | UNIT | | |
|---------------------------|--------------------|--------------------|---------|----|--|
| Collector-Base Voltage | | V _{CBO} | 900 | V | |
| Collector-Emitter Voltage | | v_{CEO} | 800 | V | |
| Emitter-Base Voltage | | $v_{ m EBO}$ | 7 | V | |
| Collector Current | DC | IC | 3 | A | |
| | Pulse | ICP | 5 | | |
| Base Current | | IB | 1 | A | |
| Collector Power | Ta=25°C | Da | 1.5 | w | |
| Dissipation | $Tc = 25^{\circ}C$ | -PC | 40 | | |
| Junction Temperature | | $\mathrm{T_{j}}$ | 150 | °C | |
| Storage Temperature Range | | $\mathrm{T_{stg}}$ | -55~150 | °C | |

INDUSTRIAL APPLICATIONS

Unit in mm



2-10A1A

Weight: 1.9g

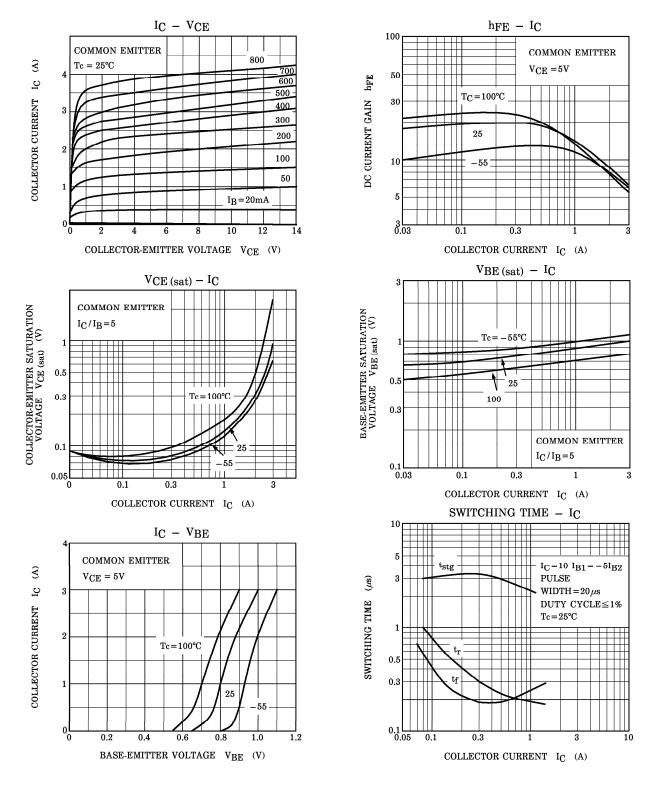
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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

| | • | | | | | | |
|---|--------------|-----------------------|---|------|------|------|---------|
| CHARACTERISTIC | | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT |
| Collector Cut-off Current | | ICBO | $V_{CB} = 800V, I_{E} = 0$ | _ | _ | 100 | μA |
| Emitter Cut-off Current | | I _{EBO} | $V_{EB} = 7V, I_{C} = 0$ | _ | _ | 1 | mA |
| Collector-Base B Voltage | reakdown | V (BR) CBO | $I_{\rm C}=1$ mA, $I_{\rm E}=0$ | 900 | _ | _ | V |
| Collector-Emitter Breakdown Voltage | | V (BR) CEO | $I_{\rm C} = 10 {\rm mA}, I_{\rm B} = 0$ | 800 | _ | | V |
| DC Current Gain | | ${ m h_{FE}}$ | $V_{CE}=5V$, $I_{C}=0.8A$ | 10 | _ | _ | |
| Collector-Emitter Saturation Voltage | | V _{CE} (sat) | I_{C} =0.8A, I_{B} =0.16 A | _ | _ | 0.6 | V |
| Base-Emitter Saturation Voltage | | V _{BE} (sat) | $I_{\rm C} = 0.8 \text{V}, \ I_{\rm B} = 0.16 \text{A}$ | _ | _ | 1.2 | V |
| Switching Time | Rise Time | t _r | $\begin{array}{c ccccccccccccccccccccccccccccccccccc$ | _ | | 1.0 | |
| | Storage Time | t_{stg} | | _ | _ | 4.0 | μ s |
| | Fall Time | t_f | | | | 1.0 | |

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